

Notice of References Cited

Application/Control No. 09/195,080

Applicant(s)/Patent Under Reexamination KEIKO ET AL.

Examiner

Kevin C. Harper

Art Unit 2664

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,185,213	02-2001	Katsube et al.	370/396
	В	US-6,009,097	12-1999	Han, Yih-Wu	370/395.52
<u> </u>	С	US-5,909,441	06-1999	Alexander et al.	370/395.53
	D	US-6,064,675	05-2000	Alexander et al.	370/397
	E	US-6,185,215	02-2001	Aho, Michael E.	370/218
	F	US-6,172,991	01-2001	Mori, Naoki	370/389
-	G	US-6,188,689	02-2001	Katsube et al.	370/252
<u> </u>	-	US-			
<u> </u>	H				
ļ		US-	<u> </u>		
	J	US-			
	ĸ	US-			
	L	US-			
	М	US			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					· · · · · · · · · · · · · · · · · · ·
	Р					
	Q					
	R					
	S					
	Т					
		<u> </u>		NON DATENT DOCUM	CNITO	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
L		
	U	
1		
	l v l	
	'	
-		
	l w	
	۷۷	
L	<u> </u>	
1	X	
l	1	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.